

Dual N-channel MOSFET

ELM14800AA-N

■ General description

ELM14800AA-N uses advanced trench technology to provide excellent $R_{ds(on)}$ and low gate charge.

■ Features

- $V_{ds}=30V$
- $I_d=6.9A$ ($V_{gs}=10V$)
- $R_{ds(on)} < 27m\Omega$ ($V_{gs}=10V$)
- $R_{ds(on)} < 32m\Omega$ ($V_{gs}=4.5V$)
- $R_{ds(on)} < 50m\Omega$ ($V_{gs}=2.5V$)

■ Maximum absolute ratings

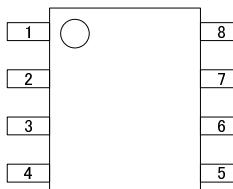
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	30	V	
Gate-source voltage	V_{gs}	± 12	V	
Continuous drain current Ta=25°C	I_d	6.9	A	1
Ta=70°C		5.8		
Pulsed drain current	I_{dm}	40	A	2
Power dissipation Ta=25°C	P_d	2.00	W	
Ta=70°C		1.44		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	°C	

■ Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	t≤10s	$R_{\theta ja}$	48.0	62.5	°C/W	1
Maximum junction-to-ambient	Steady-state		74.0	110.0	°C/W	
Maximum junction-to-lead	Steady-state	$R_{\theta jl}$	35.0	40.0	°C/W	3

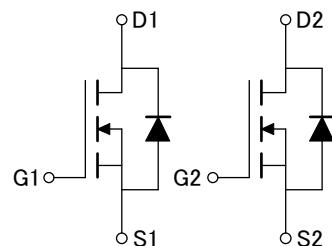
■ Pin configuration

SOP-8 (TOP VIEW)



Pin No.	Pin name
1	SOURCE2
2	GATE2
3	SOURCE1
4	GATE1
5	DRAIN1
6	DRAIN1
7	DRAIN2
8	DRAIN2

■ Circuit



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■ Electrical characteristics

$T_a=25^\circ C$

Parameter	Symbol	Condition		Min.	Typ.	Max.	Unit
STATIC PARAMETERS							
Drain-source breakdown voltage	BVdss	$I_d=250\mu A$, $V_{gs}=0V$		30			V
Zero gate voltage drain current	Idss	$V_{ds}=24V$			0.002	1.000	μA
		$V_{gs}=0V$	$T_j=55^\circ C$			5.000	
Gate-body leakage current	Igss	$V_{ds}=0V$, $V_{gs}=\pm 12V$				100	nA
Gate threshold voltage	Vgs(th)	$V_{ds}=V_{gs}$, $I_d=250\mu A$		0.7	1.0	1.4	V
On state drain current	$I_d(on)$	$V_{gs}=4.5V$, $V_{ds}=5V$		25			A
Static drain-source on-resistance	Rds(on)	$V_{gs}=10V$			22.6	27.0	$m\Omega$
		$I_d=6.9A$	$T_j=125^\circ C$		33.0	40.0	
		$V_{gs}=4.5V$, $I_d=6A$			27.0	32.0	$m\Omega$
		$V_{gs}=2.5V$, $I_d=5A$			42.0	50.0	$m\Omega$
Forward transconductance	Gfs	$V_{ds}=5V$, $I_d=5A$		12	16		S
Diode forward voltage	Vsd	$I_s=1A$			0.71	1.00	V
Max. body-diode continuous current	Is					3	A
DYNAMIC PARAMETERS							
Input capacitance	Ciss	$V_{gs}=0V$, $V_{ds}=15V$, $f=1MHz$			858	1050	pF
Output capacitance	Coss				110		pF
Reverse transfer capacitance	Crss				80		pF
Gate resistance	Rg	$V_{gs}=0V$, $V_{ds}=0V$, $f=1MHz$			1.24	3.60	Ω
SWITCHING PARAMETERS							
Total gate charge	Qg	$V_{gs}=4.5V$, $V_{ds}=15V$, $I_d=6.9A$			9.60	12.00	nC
Gate-source charge	Qgs				1.65		nC
Gate-drain charge	Qgd				3.00		nC
Turn-on delay time	td(on)	$V_{gs}=10V$, $V_{ds}=15V$			3.2	4.8	ns
Turn-on rise time	tr				4.1	6.2	ns
Turn-off delay time	td(off)		$R_L=2.2\Omega$, $R_{gen}=3\Omega$		26.3	40.0	ns
Turn-off fall time	tf				3.7	5.5	ns
Body diode reverse recovery time	trr	$I_f=5A$, $dl/dt=100A/\mu s$			15.5	20.0	ns
Body diode reverse recovery charge	Qrr	$I_f=5A$, $dl/dt=100A/\mu s$			7.9	12.0	nC

NOTE :

1. The value of $R_{\theta ja}$ is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with $T_a=25^\circ C$. The value in any given applications depends on the user's specific board design, The current rating is based on the $t \leq 10s$ thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The $R_{\theta ja}$ is the sum of the thermal impedance from junction to lead $R_{\theta jl}$ and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25^\circ C$. The SOA curve provides a single pulse rating.

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■ Typical electrical and thermal characteristics

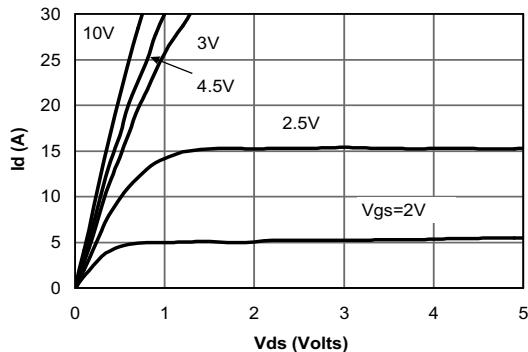


Fig 1: On-Region Characteristics

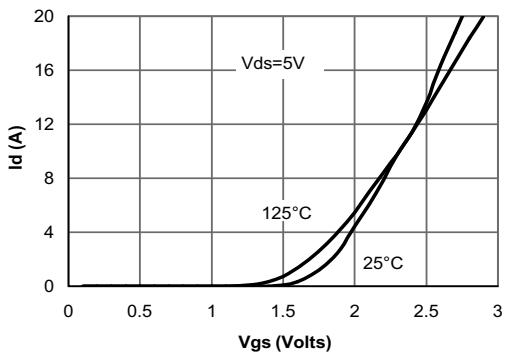


Figure 2: Transfer Characteristics

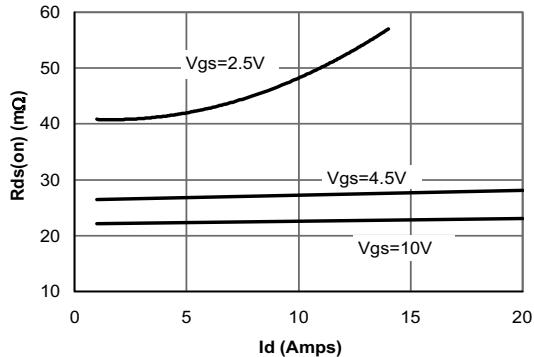


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

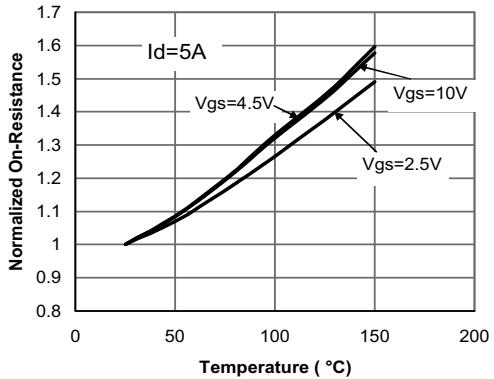


Figure 4: On-Resistance vs. Junction Temperature

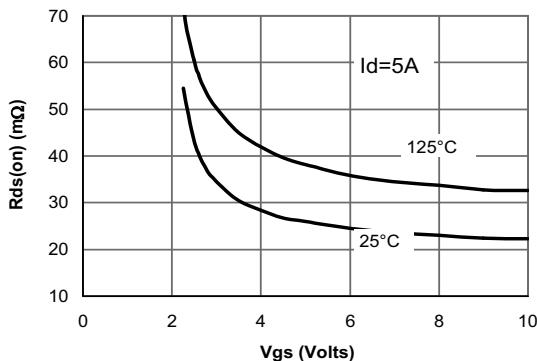


Figure 5: On-Resistance vs. Gate-Source Voltage

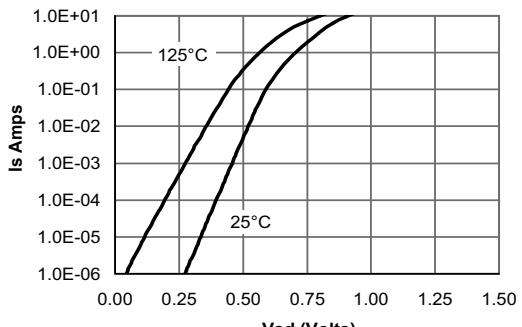


Figure 6: Body diode characteristics

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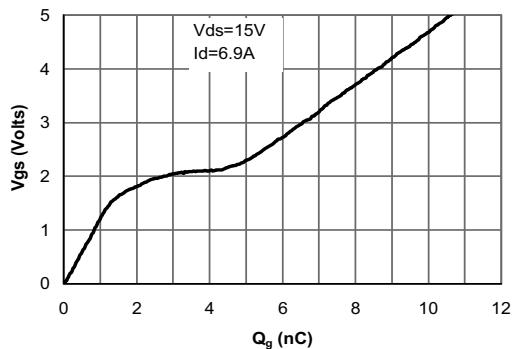


Figure 7: Gate-Charge characteristics

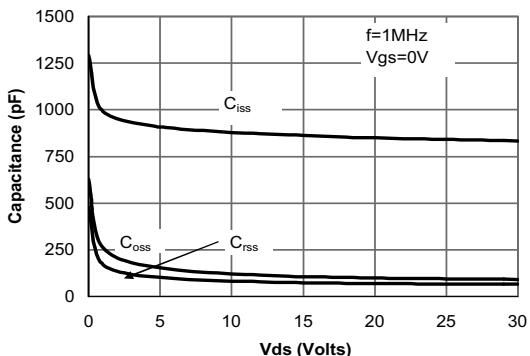


Figure 8: Capacitance Characteristics

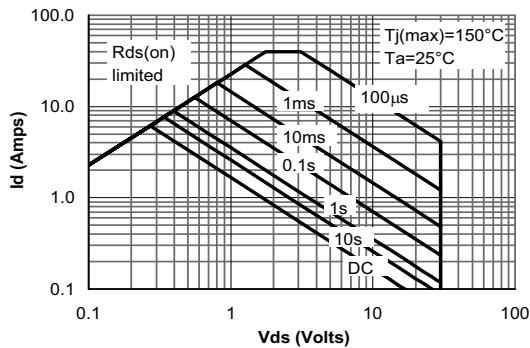


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

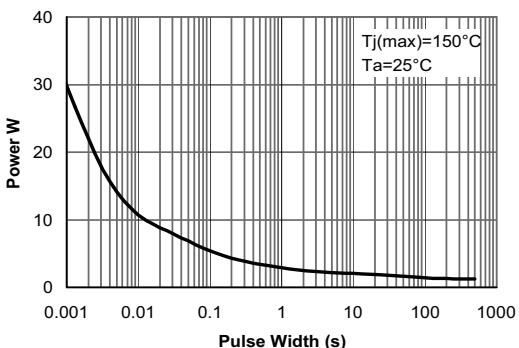


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

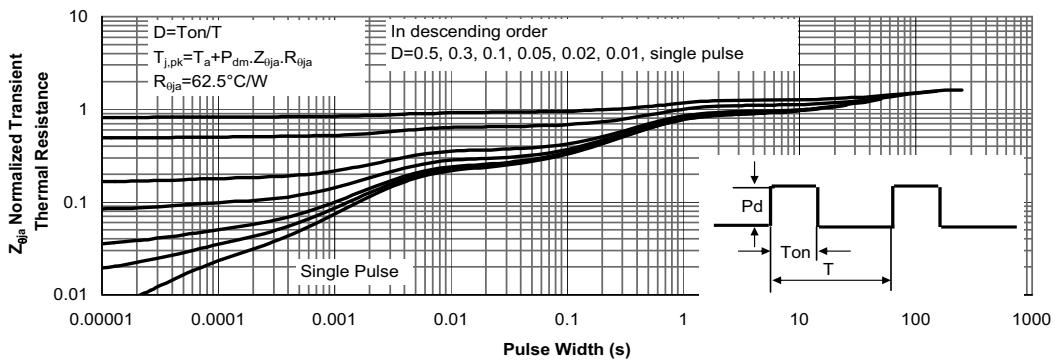


Figure 11: Normalized Maximum Transient Thermal Impedance